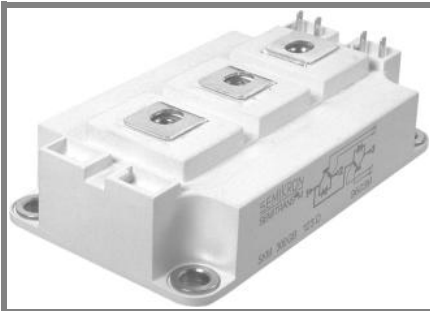


# SKM 150GB123D



**SEMITRANS® 3**

## IGBT Modules

**SKM 150GB123D**

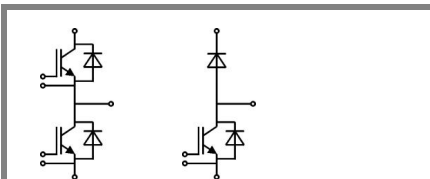
**SKM 150GAL123D**

### Features

- MOS input (voltage controlled)
- N channel, Homogeneous Si
- Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to  $6 \times I_{Cnom}$
- Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DCB Direct Copper Bonding
- Large clearance (12 mm) and creepage distances (20 mm)

### Typical Applications\*

- AC inverter drives
- UPS



**GB**

**GAL**

Absolute Maximum Ratings		$T_c = 25^\circ\text{C}$ , unless otherwise specified		
Symbol	Conditions	Values		Units
<b>IGBT</b>				
$V_{CES}$	$T_j = 25^\circ\text{C}$	1200		V
$I_C$	$T_j = 150^\circ\text{C}$	$T_{case} = 25^\circ\text{C}$	150	A
		$T_{case} = 80^\circ\text{C}$	110	A
$I_{CRM}$	$I_{CRM} = 2 \times I_{Cnom}$	200		A
$V_{GES}$		$\pm 20$		V
$t_{psc}$	$V_{CC} = 600\text{ V}; V_{GE} \leq 20\text{ V}; T_j = 125^\circ\text{C}$ $V_{CES} < 1200\text{ V}$	10		$\mu\text{s}$
<b>Inverse Diode</b>				
$I_F$	$T_j = 150^\circ\text{C}$	$T_{case} = 25^\circ\text{C}$	150	A
		$T_{case} = 80^\circ\text{C}$	100	A
$I_{FRM}$	$I_{FRM} = 2 \times I_{Fnom}$	200		A
$I_{FSM}$	$t_p = 10\text{ ms}; \text{sin.}$	$T_j = 150^\circ\text{C}$	1100	A
<b>Freewheeling Diode</b>				
$I_F$	$T_j = 150^\circ\text{C}$	$T_{case} = 25^\circ\text{C}$	200	A
		$T_{case} = 80^\circ\text{C}$	135	A
$I_{FRM}$		300		A
$I_{FSM}$	$t_p = 10\text{ ms}; \text{sin.}$	$T_j = 150^\circ\text{C}$	1440	A
<b>Module</b>				
$I_{t(RMS)}$		500		A
$T_{vj}$		- 40 ... + 150		$^\circ\text{C}$
$T_{stg}$		-40 ... + 125		$^\circ\text{C}$
$V_{isol}$	AC, 1 min.	2500		V

Characteristics		$T_c = 25^\circ\text{C}$ , unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
<b>IGBT</b>					
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 4\text{ mA}$	4,5	5,5	6,5	V
$I_{CES}$	$V_{GE} = 0\text{ V}, V_{CE} = V_{CES}$	$T_j = 25^\circ\text{C}$	0,1		mA
		$T_j = 125^\circ\text{C}$	0,3		mA
$V_{CE0}$		$T_j = 25^\circ\text{C}$	1,4	1,6	V
		$T_j = 125^\circ\text{C}$	1,6	1,8	V
$r_{CE}$	$V_{GE} = 15\text{ V}$	$T_j = 25^\circ\text{C}$	11	14	$\text{m}\Omega$
		$T_j = 125^\circ\text{C}$	15	19	$\text{m}\Omega$
$V_{CE(sat)}$	$I_{Cnom} = 100\text{ A}, V_{GE} = 15\text{ V}$	$T_j = ^\circ\text{C}_{chiplev.}$	2,5	3	V
$C_{ies}$	$V_{CE} = 25, V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	6,5		nF
$C_{oes}$			1		nF
$C_{res}$			0,5		nF
$Q_G$	$V_{GE} = -8\text{ V} - +20\text{ V}$		1000		nC
$R_{Gint}$	$T_j = ^\circ\text{C}$	2,5		$\Omega$	
$t_{d(on)}$	$R_{Gon} = 6,8\ \Omega$	$V_{CC} = 600\text{ V}$ $I_C = 100\text{ A}$	160	320	ns
			80	160	ns
$E_{on}$	$R_{Goff} = 6,8\ \Omega$	$T_j = 125^\circ\text{C}$ $V_{GE} = \pm 15\text{ V}$	13		mJ
$t_{d(off)}$			400		ns
$t_f$			70		ns
$E_{off}$			11		mJ
$R_{th(j-c)}$	per IGBT		0,15		K/W



**SEMITRANS® 3**

## IGBT Modules

**SKM 150GB123D**

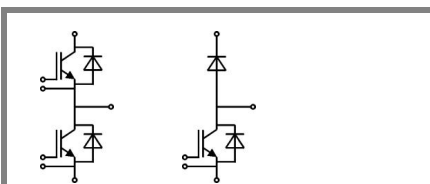
**SKM 150GAL123D**

### Features

- MOS input (voltage controlled)
- N channel, Homogeneous Si
- Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to  $6 \times I_{cnom}$
- Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DCB Direct Copper Bonding
- Large clearance (12 mm) and creepage distances (20 mm)

### Typical Applications\*

- AC inverter drives
- UPS



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### Characteristics

Symbol	Conditions	min.	typ.	max.	Units
<b>Inverse Diode</b>					
$V_F = V_{EC}$	$I_{Fnom} = 100 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}_{chiplev.}$	2	2,5	V
		$T_j = 125 \text{ }^\circ\text{C}_{chiplev.}$	1,8		V
$V_{F0}$		$T_j = 25 \text{ }^\circ\text{C}$	1,1	1,2	V
		$T_j = 125 \text{ }^\circ\text{C}$			V
$r_F$		$T_j = 25 \text{ }^\circ\text{C}$	9	13	mΩ
		$T_j = 125 \text{ }^\circ\text{C}$			mΩ
$I_{RRM}$	$I_F = 100 \text{ A}$	$T_j = 125 \text{ }^\circ\text{C}$	50		A
$Q_{rr}$	$di/dt = 1000 \text{ A}/\mu\text{s}$		5		μC
$E_{rr}$	$V_{GE} = 0 \text{ V}; V_{CC} = 600 \text{ V}$				mJ
$R_{th(j-c)D}$	per diode			0,3	K/W
<b>Freewheeling Diode</b>					
$V_F = V_{EC}$	$I_{Fnom} = 150 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}_{chiplev.}$	2	2,5	V
		$T_j = 125 \text{ }^\circ\text{C}_{chiplev.}$	1,8		V
$V_{F0}$		$T_j = 25 \text{ }^\circ\text{C}$	1,1	1,2	V
		$T_j = 125 \text{ }^\circ\text{C}$			V
$r_F$		$T_j = 25 \text{ }^\circ\text{C}$	6	8,7	V
		$T_j = 125 \text{ }^\circ\text{C}$			V
$I_{RRM}$	$I_F = 100 \text{ A}$	$T_j = 25 \text{ }^\circ\text{C}$	40		A
$Q_{rr}$			5		μC
$E_{rr}$	$V_{GE} = 0 \text{ V}; V_{CC} = 600 \text{ V}$				mJ
$R_{th(j-c)FD}$	per diode			0,25	K/W
<b>Module</b>					
$L_{CE}$			15	20	nH
$R_{CC'+EE'}$	res., terminal-chip	$T_{case} = 25 \text{ }^\circ\text{C}$	0,35		mΩ
		$T_{case} = 125 \text{ }^\circ\text{C}$	0,5		mΩ
$R_{th(c-s)}$	per module			0,038	K/W
$M_s$	to heat sink M6		3	5	Nm
$M_t$	to terminals M6		2,5	5	Nm
w				325	g

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

\* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.

# SKM 150GB123D



**SEMITRANS® 3**

## IGBT Modules

**SKM 150GB123D**

**SKM 150GAL123D**

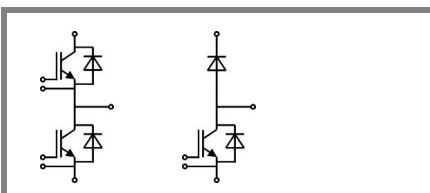
### Features

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### Typical Applications\*

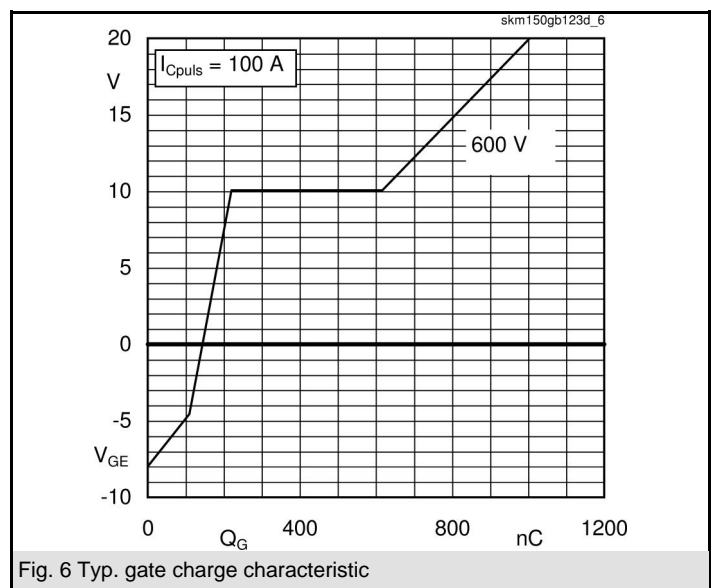
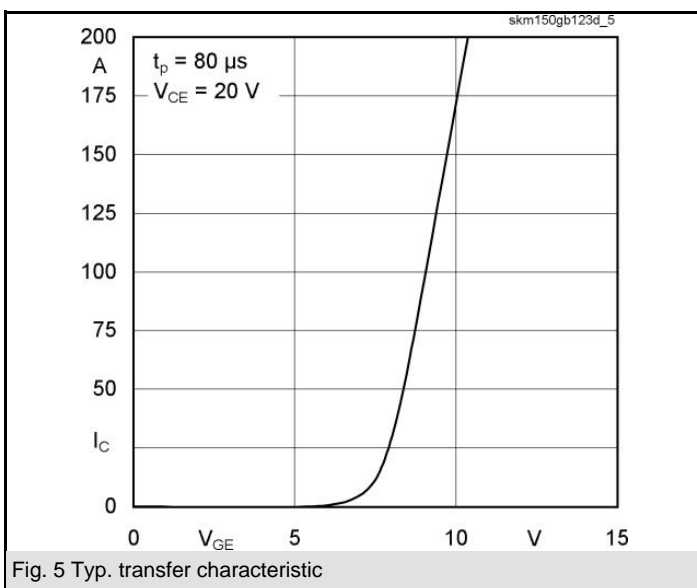
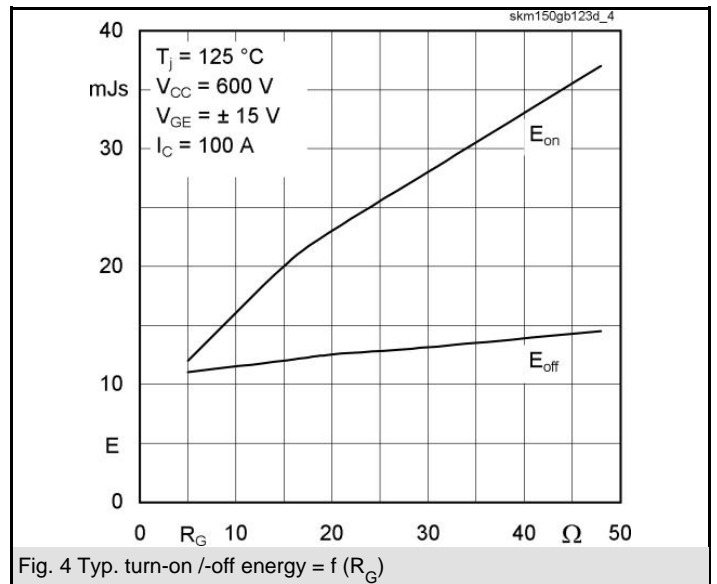
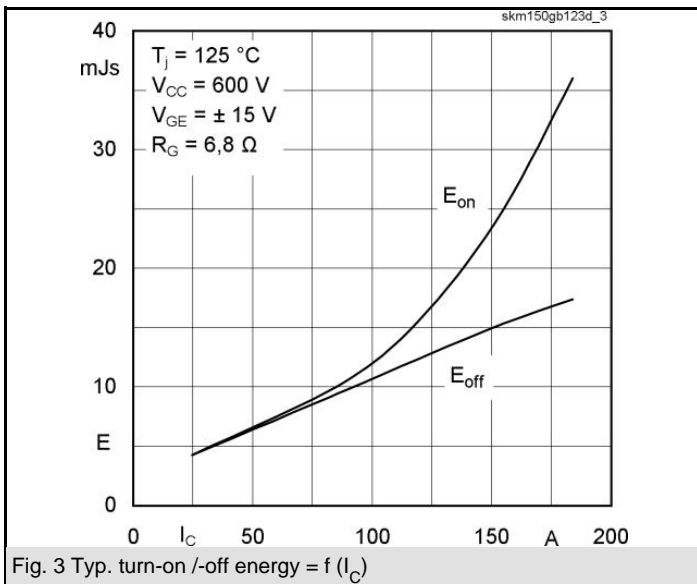
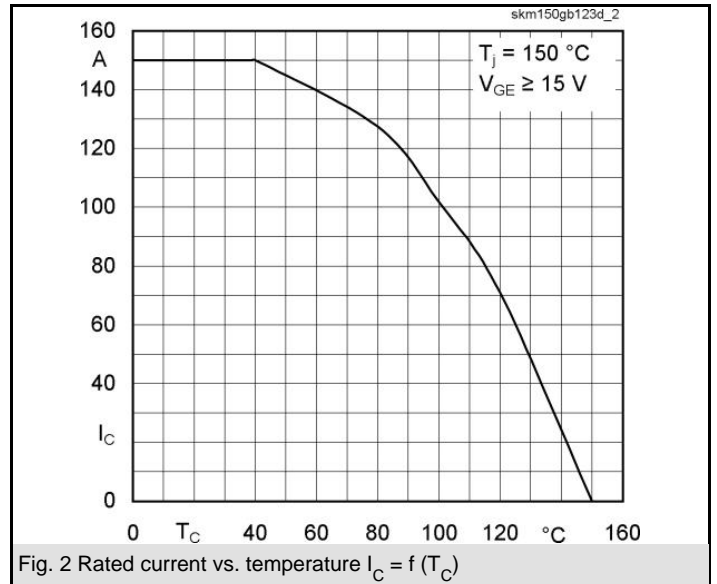
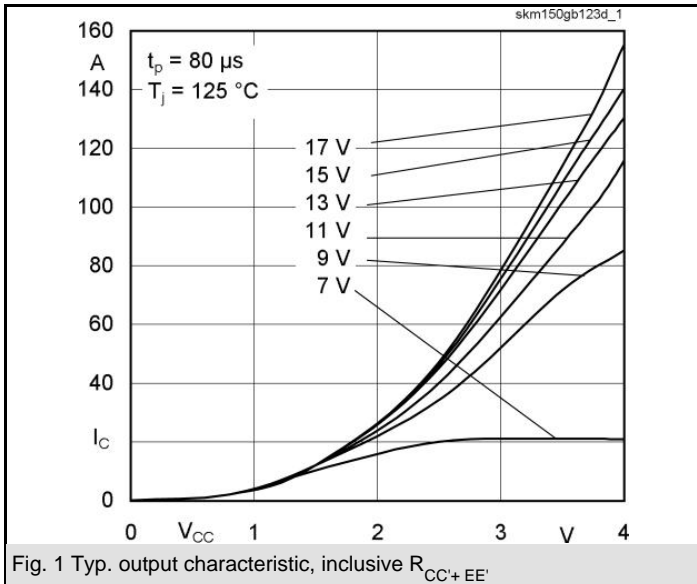
- AC inverter drives
- UPS

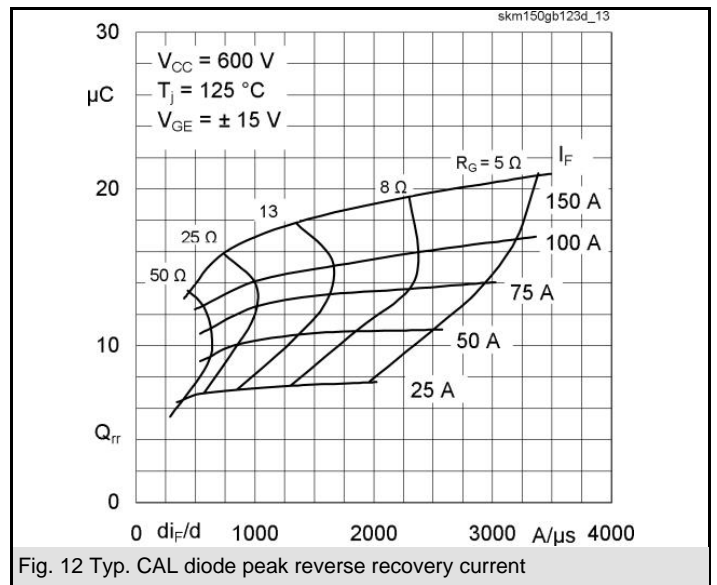
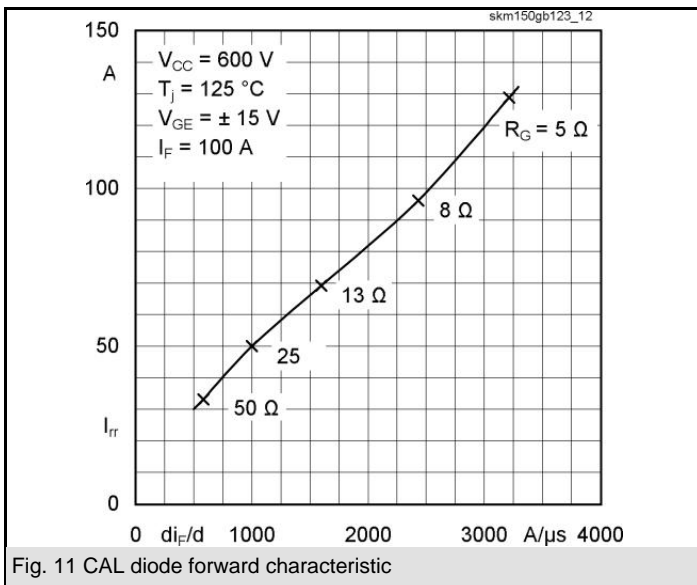
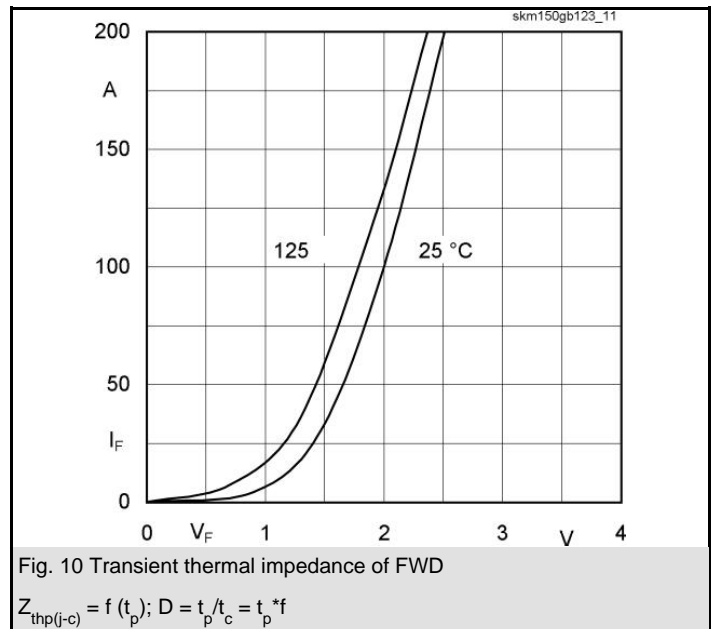
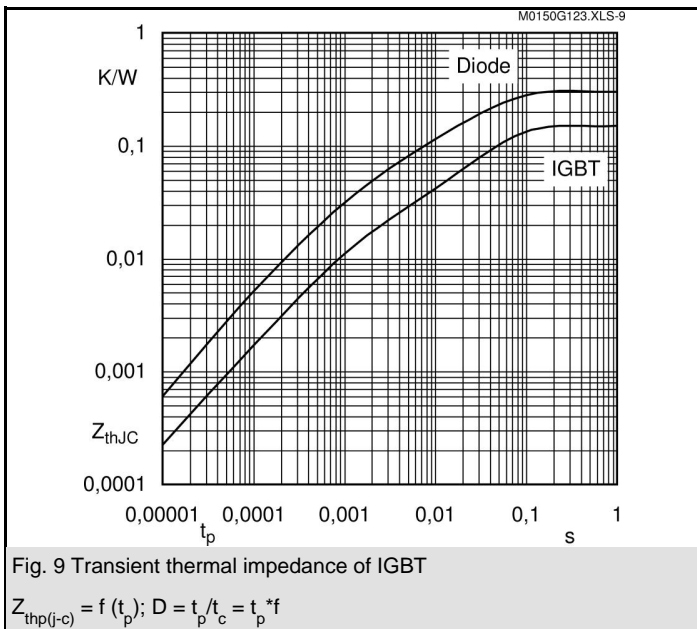
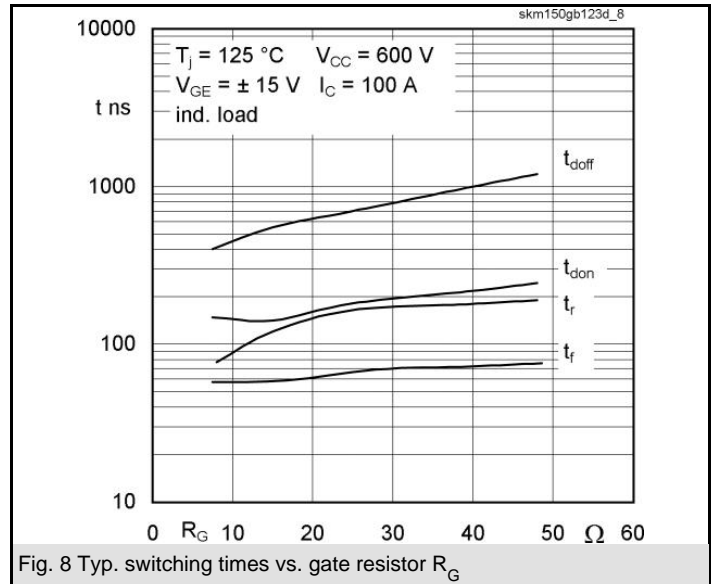
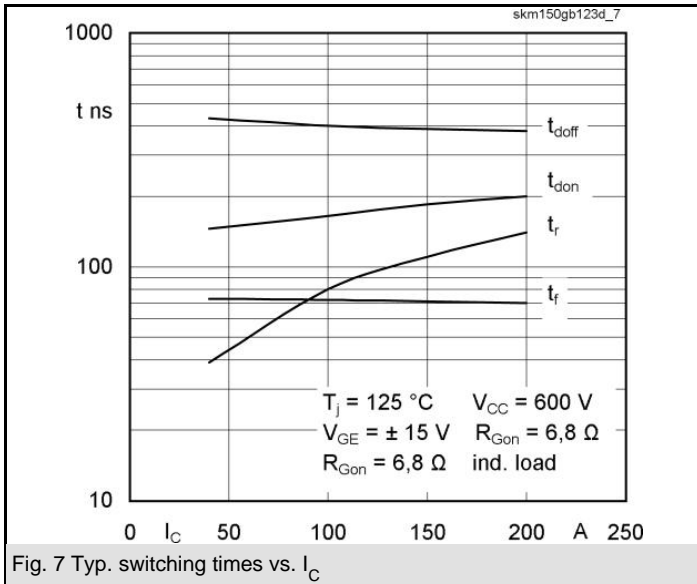
$Z_{th}$		Conditions	Values	Units
<b><math>Z_{th(j-c)I}</math></b>				
$R_{\theta j-c}$	$i = 1$		105	mk/W
$R_{\theta j-c}$	$i = 2$		35	mk/W
$R_{\theta j-c}$	$i = 3$		8	mk/W
$R_{\theta j-c}$	$i = 4$		2	mk/W
$\tau_{th(j-c)}$	$i = 1$		0,03	s
$\tau_{th(j-c)}$	$i = 2$		0,03	s
$\tau_{th(j-c)}$	$i = 3$		0,0014	s
$\tau_{th(j-c)}$	$i = 4$		0,0001	s
<b><math>Z_{th(j-c)D}</math></b>				
$R_{\theta j-cD}$	$i = 1$		210	mk/W
$R_{\theta j-cD}$	$i = 2$		70	mk/W
$R_{\theta j-cD}$	$i = 3$		16	mk/W
$R_{\theta j-cD}$	$i = 4$		4	mk/W
$\tau_{th(j-c)D}$	$i = 1$		0,0623	s
$\tau_{th(j-c)D}$	$i = 2$		0,0083	s
$\tau_{th(j-c)D}$	$i = 3$		0,003	s
$\tau_{th(j-c)D}$	$i = 4$		0,0002	s



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# SKM 150GB123D

UL Recognized

CASED56

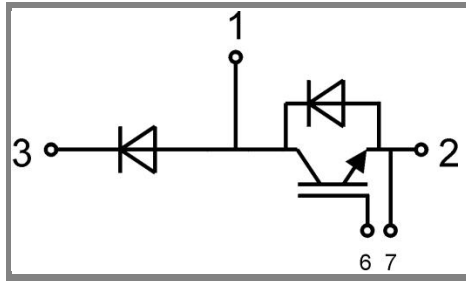
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Case D 56



GB Case D 56



GAL Case D 57 (→ D 56)